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- Functionally Equivalent to AMD's AM29823
- Provide Extra Data Width Necessary for Wider Address/Data Paths or Buses With Parity
- Outputs Have Undershoot-Protection Circuitry
- Power-Up High-Impedance State
- Buffered Control Inputs Reduce dc Loading Effects
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (NT) and Ceramic (JT) 300-mil DIPs

description

These 9-bit flip-flops feature 3-state outputs designed specifically for driving highly capacitive

or relatively low-impedance loads. They are particularly suitable for implementing wider buffer registers, I/O ports, bidirectional bus drivers, parity bus interfacing, and working registers.

With the clock-enable (CLKEN) input low, the nine D-type edge-triggered flip-flops enter data on the low-to-high transitions of the clock (CLK) input. Taking CLKEN high disables the clock buffer, latching the outputs. The 'ALS29823 have noninverting data (D) inputs. Taking the clear (CLR) input low causes the nine Q outputs to go low independently of the clock.

A buffered output-enable (\overline{OE}) input places the nine outputs in either a normal logic state (high or low logic levels) or a high-impedance state. The outputs also are in the high-impedance state during power-up and power-down conditions. The outputs remain in the high-impedance state while the device is powered down. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

OE does not affect the internal operation of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54ALS29823 is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74ALS29823 is characterized for operation from 0°C to 70°C.

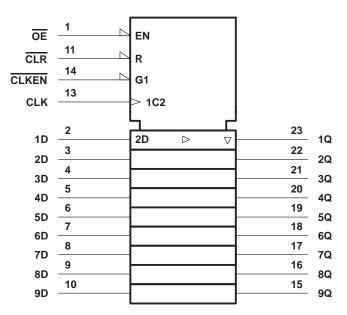
FUNCTION TABLE (each flip-flop)									
		INPUTS			OUTPUT				
OE	CLR	CLKEN	CLK	D	Q				
L	L	Х	Х	Х	L				
L	Н	L	\uparrow	н	Н				
L	Н	L	\uparrow	L	L				
L	Н	Н	Х	Х	Q ₀				
н	Х	Х	Х	Х	Z				

SN74ALS29823 DW OR NT PACKAGE (TOP VIEW)										
OE [1D [2D [3D [4D [5D [7D [8D [9D [GND [1 2 3 4 5 6 7 8 9 10 11 12	24 23 22 21 20 19 18 17 16 15 14 13	V _{CC} 1Q 2Q 3Q 4Q 5Q 6Q 7Q 8Q 9Q CLKEN CLK							

SN54ALS29823 . . . JT PACKAGE

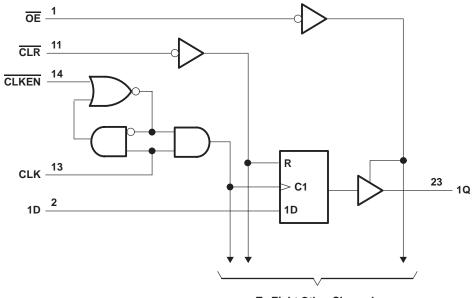
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logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



To Eight Other Channels



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V _{CC}	
Input voltage, V _I	5.5 V
Voltage applied to a disabled high-impedance output	5.5 V
Operating free-air temperature range, T _A : SN54ALS29823	-55°C to 125°C
Storage temperature range	-65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

				SN5	4ALS29	823	UNIT	
				MIN	NOM	MAX	UNIT	
VCC	Supply voltage			4.5	5	5.5	V	
VIH	High-level input voltage			2			V	
VIL	Low-level input voltage					0.8	V	
IOH	High-level output current					-18	mA	
IOL	Low-level output current					32	mA	
+	Pulse duration		CLR low	7			50	
tw	Fuse duration	CLK high or low		8			ns	
		CLR inactive		7				
t _{su}	Setup time before CLK↑	[Data	4			ns	
		ſ	CLKEN high or low	8				
4.			CLKEN	2				
th	Hold time after CLK [↑] Data		Data	4			ns	
Тд	Operating free-air temperature			-55	25	125	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	7507.0		SN5	4ALS29	823	UNIT
PARAMETER	TEST CO	TEST CONDITIONS				
VIK	$V_{CC} = 4.5 V,$	lj = -18 mA			-1.2	V
Vou	VCC = 4.5 V	I _{OH} = -12 mA	2.4	3.3		V
VOH	VCC = 4.5 V	I _{OH} = -18 mA	2			v
V _{OL}	$V_{CC} = 4.5 V,$	I _{OL} = 32 mA		0.25	0.5	V
^I OZH	V _{CC} = 5.5 V,	V _O = 2.4 V			50	μA
lozl	V _{CC} = 5.5 V,	V _O = 0.4 V			-50	μA
Ιį	V _{CC} = 5.5 V,	V _I = 5.5 V			0.1	mA
Чн	V _{CC} = 5.5 V,	V _I = 2.7 V			20	μA
Ι _{ΙL}	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.5	mA
IOS§	V _{CC} = 5.5 V,	VO = 0	-75		-250	mA
		Outputs high			90	
lcc	$V_{CC} = 5.5 V$	Outputs low		10		mA
		Outputs open			115	

[‡] All typical values are at V_{CC} = 5 V, $T_A = 25^{\circ}C$.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.



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switching characteristics (see Figure 1)

	FROM	FROM TO		V _{CC} = MIN T _A = MIN t	V _{CC} = MIN to MAX [†] , T _A = MIN to MAX [†]		
PARAMETER	(INPUT)	(OUTPUT)	TEST CONDITIONS	SN54AL	S29823	UNIT	
				MIN	MAX		
^t PLH	CLK	1.00	0. 50.55	2	11.5	ns	
^t PHL	CLK	Any Q	C _L = 50 pF	2	11.5	115	
^t PLH	CLK	4	0 000 - 5	2	21	ns	
^t PHL		Any Q	C _L = 300 pF	2	21	115	
^t PHL	CLR	Any Q	C _L = 50 pF	1	17.5	ns	
^t PZH	OE	Anv	0 50 - 5	1	17	ns	
^t PZL	ÛE	Any Q	C _L = 50 pF	1	17	115	
^t PZH	OE			1	25	ns	
^t PZL	ÛE	Any Q	C _L = 300 pF	1	29.5	115	
^t PHZ	ŌĒ	4	0 50 5	1	16		
^t PLZ	UE	Any Q	C _L = 50 pF	1	14	ns	
^t PHZ	ŌĒ	Any Q	C _L = 5 pF	1	12		
^t PLZ	UE	Ally Q	CL = 2 hr	1	11	ns	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage, V _{CC}	7 V
Input voltage, V _I	5 V
Voltage applied to a disabled 3-state output 5.5	5 V
Operating free-air temperature range, T _A : SN74ALS29823 0°C to 70	Э°С
Storage temperature range	Э°С

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

			SN7	4ALS29	823	UNIT	
			MIN	NOM	MAX	UNIT	
VCC	Supply voltage		4.75	5	5.25	V	
VIH	High-level input voltage		2			V	
VIL	Low-level input voltage				0.8	V	
IOH	High-level output current				-24	mA	
IOL	Low-level output current				48	mA	
	Pulse duration	CLR low	5				
tw	Fuse duration	CLK high or low				ns	
		CLR inactive	5				
t _{su}	Setup time before CLK [↑]	Data	2			ns	
		CLKEN high or low	6				
4		CLKEN	0				
th	Hold time after CLK [↑] Data		2			ns	
TA	Operating free-air temperature		0	25	70	°C	



SN54ALS29823, SN74ALS29823 9-BIT BUS-INTERFACE FLIP-FLOPS WITH 3-STATE OUTPUTS SDAS146B – JANUARY 1986 – REVISED JANUARY 1995

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			SN7	4ALS29	823	UNIT
PARAMETER	TEST CO	TEST CONDITIONS				
VIK	V _{CC} = 4.75 V,	lj = – 18 mA			-1.2	V
)/au		$I_{OH} = -15 \text{ mA}$	2.4	3.3		V
VOH	V _{CC} = 4.75 V	$I_{OH} = -24 \text{ mA}$	2	3.1		v
V _{OL}	V _{CC} = 4.75 V,	I _{OL} = 48 mA		0.35	0.5	V
Іодн	V _{CC} = 5.25 V,	V _O = 2.4 V			20	μA
lozl	V _{CC} = 5.25 V,	$V_{O} = 0.4 V$			-20	μA
lı lı	V _{CC} = 5.25 V,	V _I = 5.5 V			0.1	mA
μн	V _{CC} = 5.25 V,	V _I = 2.7 V			20	μA
lιL	V _{CC} = 5.25 V,	V _I = 0.4 V			-0.2	mA
los‡	V _{CC} = 5.25 V,	$V_{O} = 0$	-75		-250	mA
ICC	V _{CC} = 5.25 V,	Outputs open		80	115	mA

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡]Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

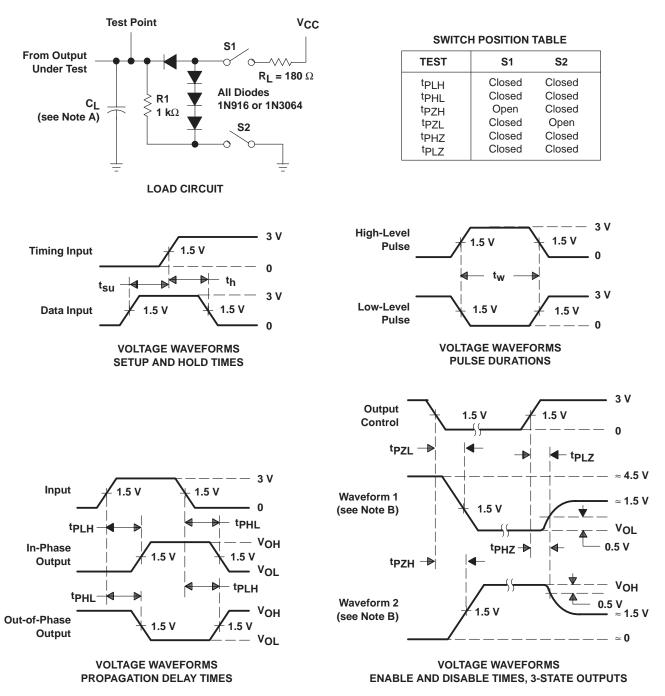
switching characteristics (see Figure 1)

	FROM	то		V _{CC} = MIN T _A = MIN t	l to MAX§, o MAX§		
PARAMETER	(INPUT)	(OUTPUT)	TEST CONDITIONS	SN74AL	S29823	UNIT	
				MIN	MAX		
tPLH	CLK	Amy O	C. 50 mF	2	10	ns	
^t PHL	OLK	Any Q	C _L = 50 pF	2	10	115	
^t PLH	CLK	40	0 000 - 5		16	ns	
^t PHL		Any Q	C _L = 300 pF		16	115	
^t PHL	CLR	Any Q	C _L = 50 pF		12	ns	
^t PZH	OE				14	ns	
tPZL	ÛE	Any Q	C _L = 50 pF		14	115	
^t PZH	OE	T			20		
^t PZL	ÛE	Any Q	C _L = 300 pF		23	ns	
^t PHZ	OE				14		
^t PLZ	UE	Any Q	C _L = 50 pF		12	ns	
^t PHZ	$\frac{t_{\text{PHZ}}}{\text{OE}}$ Any Q C ₁ = 5		C _L = 5 pF		9		
^t PLZ	UE	Any Q	CL = 5 PF		9	ns	

§ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_f ≤ 2.5 ns, t_f ≤ 2.5 ns.

Figure 1. Load Circuit and Voltage Waveforms





17-Dec-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN74ALS29823DW	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI	0 to 70		
SN74ALS29823DWR	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI	0 to 70		
SN74ALS29823NT	OBSOLETE	PDIP	NT	24		TBD	Call TI	Call TI	0 to 70		

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and package die adhesive used between the die adhesive used between the die and package die adhesive used between the die adhesive use

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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17-Dec-2015

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OTHER QUALIFIED VERSIONS OF SN54ALS29823, SN74ALS29823 :

• Catalog: SN74ALS29823

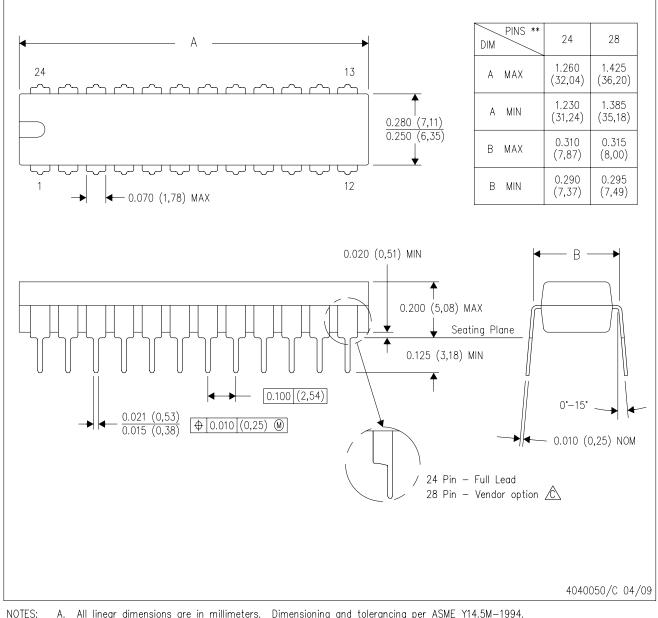
Military: SN54ALS29823

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

NT (R-PDIP-T**) 24 pins shown

PLASTIC DUAL-IN-LINE PACKAGE



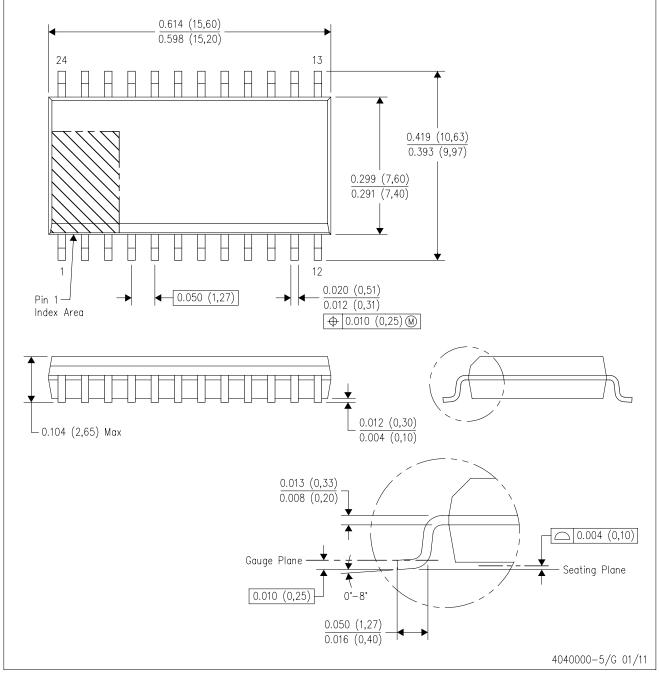
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 B. This drawing is subject to change without notice.

The 28 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



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